

**Search Notes**

Application/Control No.

10/052,122

Examiner

Charlotte M. Baker

Applicant(s)/Patent under  
Reexamination

NISHIDA ET AL.

Art Unit

2626

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Primary Examiner Madeleine Nguyen	12/8/2005	CMB